

<b>Notice of References Cited</b>	Application/Control No. 10/701,871	Applicant(s)/Patent Under Reexamination GUO ET AL.	
	Examiner S. Devi, Ph.D.	Art Unit 1645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,573,921	11-1996	Behnke et al.	435/7.92
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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	Q					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Werfel et al. J. Immunol. 157: 1729-1735, 1996
	V	Rothermel et al. Scand. J. Immunol. 52: 401-410, 2000
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

SD  
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